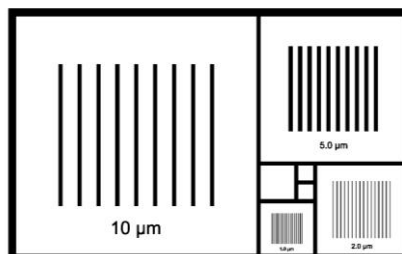
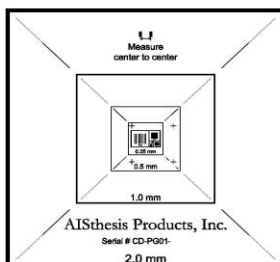


AISthesis Products, Inc.

Advanced Imaging Products for Nanotechnology, Engineering and Life Sciences

Certificate of Conformance for Critical Dimension Standard



Product Number: CDMS-1C

Product Description: 2.5x2.5mm Critical Dimension Magnification Standard

Product Serial Number: CD-PG01-0000

The accuracy of these products was determined by reference comparison to working standards traceable to the National Institute of Standards and Technology (NIST).

Line	Certified average pitch	Number of lines	Certified distance between first and last line (1σ)	Total expanded uncertainty (3σ)
2.0mm	2.00mm	2	2.00mm \pm 0.05%	\pm 0.15%
1.0mm	1.00mm	2	1.00mm \pm 0.03%	\pm 0.09%
0.5mm	0.500mm	2	0.500mm \pm 0.03%	\pm 0.09%
0.25mm	0.250mm	2	0.250mm \pm 0.03%	\pm 0.09%
10 μ m	10.00 μ m	9	80.00 μ m \pm 0.03%	\pm 0.09%
5.0 μ m	5.00 μ m	10	45.00 μ m \pm 0.03%	\pm 0.09%
2.0 μ m	2.00 μ m	16	30.00 μ m \pm 0.03%	\pm 0.09%
1.0 μ m	1.00 μ m	17	16.00 μ m \pm 0.03%	\pm 0.09%

The certified average pitch is derived from the stated certified length that was determined using 10 measurements (taken center-to-center) over the stated number of lines (i.e., length divided by the number of lines minus one). The total expanded uncertainty includes both Type A and Type B uncertainties corrected for sample size using an appropriate Student t-factor.

Equipment used:

Instrument	Model number	Serial #	NIST Certified CD/Recalibration	Resolution	Repeatability
FE-SEM	FEI Quanta 3D FEG	D8894	CD-PG01-0211/June 2013	1.2nm	0.03%

Certified by

Signature

Date

This certificate shall not be reproduced without the permission of AISthesis Products, Inc.
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